

PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

International Light Technologies

10 Technology Drive, Peabody, MA 01960

(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

ISO/IEC 17025:2017 & Meets the Requirements of ANSI/NCSI Z540.1-1994 & ANSI/NCSI Z540.3-2006 subclause 5.3

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

Calibration of Electrical and Optical Devices (As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

Tracy Szerszen
President

Perry Johnson Laboratory Accreditation, Inc. (PJLA) 755 W. Big Beaver, Suite 1325 Troy, Michigan 48084 *Initial Accreditation Date:*

Issue Date:

Expiration Date:

January 02, 2012

March 04, 2024

May 31, 2026

Accreditation No.:

Certificate No.:

66765

L24-181-1

The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: www.pjlabs.com



Certificate of Accreditation: Supplement

International Light Technologies

10 Technology Drive, Peabody, MA 01960 Contact Name: John Ellis Phone: 407-961-6383

Accreditation is granted to the facility to perform the following calibrations:

Electrical

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Research Radiometers & Photometers Fixed points F	1 mA 100 uA	3.6 x 10 ⁻⁷ A 3.4 x 10 ⁻⁸ A	Calibrator	TP-0112 TP-0113 TP-0123 TP-0135 TP-0116
	10 uA	6.2 x 10 ⁻⁹ A		
	1 uA 100 nA	6.5 x 10 ⁻¹⁰ A 7.3 x 10 ⁻¹¹ A		
	10 nA	7.9 x 10 ⁻¹² A		
	1 nA	8.4 x 10 ⁻¹³ A 2.6 x 10 ⁻¹³ A		
	100 pA 10 pA	2.6 x 10 ¹³ A		
	1 pA	4.2 x 10 ⁻¹⁴ A		

Optical

Issue: 03/2024

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Spectroradiometers Spectral Irradiance At the listed Wavelengths ^F			Calibrated Standard	OP-0152
200 nm to 350 nm	3 x 10 ⁻⁷ W/cm ² nm to 1 x 10 ⁻⁶ W/cm ² nm	4 % of Reading	Lamp	
350 nm to 400 nm	4 x 10 ⁻⁸ W/cm ² nm to 2 x 10 ⁻⁶ W/cm ² nm	3 % of Reading		
400 nm to 900 nm	6 x 10 ⁻⁶ W/cm ² nm to 2 x 10 ⁻⁵ W/cm ² nm	3 % of Reading		
900 nm to 1 050 nm	6 x 10 ⁻⁶ W/cm ² nm to 2 x 10 ⁻⁵ W/cm ² nm	7 % of Reading		
1 050 nm to 1 250 nm	6 x 10 ⁻⁶ W/cm ² nm to 2 x 10 ⁻⁵ W/cm ² nm	15 % of Reading		
1 250 nm to 2 050 nm	5 x 10 ⁻⁶ W/cm ² nm to 1.5 x 10 ⁻⁵ W/cm ² nm	7 % of Reading		
1 250 nm to 2 500 nm	2 x 10 ⁻⁶ W/cm ² nm to 6 x 10 ⁻⁶ W/cm ² nm	14 % of Reading		
Spectroradiometers Spectral Radiance At the listed Wavelengths F				OP-0152
350 nm to 400 nm	2 x 10 ⁻⁷ W/sr cm ² nm to 6 x 10 ⁻⁷ W/sr cm ² nm	3 % of Reading		
400 nm to 900 nm	2 x 10 ⁻⁶ W/sr cm ² nm to 7 x 10 ⁻⁶ W/sr cm ² nm	3 % of Reading		
900 nm to 1 050 nm	2 x 10 ⁻⁶ W/sr cm ² nm to 7 x 10 ⁻⁶ W/sr cm ² nm	7 % of Reading		



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Spectroradiometers Sp		Calibrated Standard	OP-0152	
At the listed Waveleng			Lamp	
200 nm to 350 nm	1 x 10 ⁻⁷ W/nm to 1 x 10 ⁻⁵ W/nm	4 % of Reading		
350 nm to 400 nm	2 x 10 ⁻⁷ W/nm to 1 x 10 ⁻⁵ W/nm	3 % of Reading		
400 nm to 900 nm	2.5 x 10 ⁻⁶ W/nm to 2.5 x 10 ⁻⁴ W/m	3 % of Reading		
900 nm to 1 050 nm	2.5 x 10 ⁻⁶ W/nm to 2.5 x 10 ⁻⁴ W/m	7 % of Reading		
1 050 nm to 1 250 nm	3 x 10 ⁻⁶ W/nm to 2.5 x 10 ⁻⁴ W/m	15 % of Reading		
1 250 nm to 2 050 nm	2 x 10 ⁻⁶ W/nm to 2 x 10 ⁻⁴ W/m	7 % of Reading		
1 250 nm to 2 500 nm	7 x 10 ⁻⁷ W/nm to 8 x 10 ⁻⁵ W/m	14 % of Reading		
Belt Radiometers 200 nm to 500 nm	10 mW/cm ² to 200 mW/cm ²	6.2 % of Reading	Calibrated Standard Lamp	OP-0054, OP- 0044, OP-0055, OP-0035, OP- 0053, OP-0119, OP-118, OP- 0121, OP-0124, OP-0125, OP- 120, OP-0042, OP-0013, OP- 0043
Handheld Radiometers At the listed Wavelengths F			Silicon Photodiodes Phototubes	OP-0030
200 nm to 250 nm	1 x 10 ⁻¹⁰ W/cm ² to 8 x 10 ⁻⁶ W/cm ²	11 % of Reading		
250 nm to 400 nm	1 x 10 ⁻¹⁰ W/cm ² to 7 x 10 ⁻³ W/cm ²	5 % of Reading		OP-0048, OP- 0040, OP-0050
400 nm to 960 nm	1 x 10 ⁻¹⁰ W/cm ² to 2 x 10 ⁻² W/cm ²	4 % of Reading		OP-0028, OP- 0088, OP-0094
Extended UV Scanned Irradiance At the listed Wavelengths F				OP-0036
200 nm to 250 nm	1 x 10 ⁻¹⁰ W/cm ² to 8 x 10 ⁻⁶ W/cm ²	7.1 % of Read3		
250 nm to 400 nm	1 x 10 ⁻¹⁰ W/cm ² to 7 x 10 ⁻³ W/cm ²	4.1 % of Reading	1	



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Irradiance Response At the listed Wavelengths F			Silicon Photodiodes Phototubes	OP-0131
200 nm to 250 nm	1 x 10 ⁻¹⁰ W/cm ² to 8 x 10 ⁻⁶ W/cm ²	11 % of Reading		
250 nm to 400 nm	1 x 10 ⁻¹⁰ W/cm ² to 7 x 10 ⁻³ W/cm ²	4.5 % of Reading		OP-0131, OP- 0018, OP-0098, OP-0087, OP- 0017, OP-0096, OP-0019, OP- 0007, OP-0029, OP-0131
400 nm to 960 nm	1 x 10 ⁻¹⁰ W/cm ² to 2 x 10 ⁻¹⁰ W/cm ²	3 % of Reading		OP-0029, OP- 0018, OP-0131
960 nm to 1 000 nm	1 x 10 ⁻¹⁰ W/cm ² to 1 x 10 ⁻⁴ W/cm ²	4.5 % of Reading		OP-0029, OP- 0131, OP-0002
1 000 nm to 1 100 nm	1 x 10 ⁻¹⁰ W/cm ² to 1 x 10 ⁻⁴ W/cm ²	5 % of Reading	. /	OP-0002, OP- 0018, OP-0131
Radiance Response At the listed Waveleng	ths ^F			OP-0041
200 nm to 250 nm	3 x 10 ⁻¹¹ W/cm ² /sr to 3 x 10 ⁻⁶ W/cm ² /sr	11 % of Reading		
250 nm to 400 nm	3 x 10 ⁻¹¹ W/cm ² /sr to 3 x 10 ⁻³ W/cm ² /sr	4.5 % of Reading		
400 nm to 960 nm	3 x 10 ⁻¹¹ W/cm ² /sr to 7 x 10 ⁻³ W/cm ² /sr	3 % of Reading]	
960 nm to 1 000 nm	3 x 10 ⁻¹¹ W/cm ² /sr to 3 x 10 ⁻⁵ W/cm ² /sr	4.5 % of Reading		
1 000 nm to 1 100 nm	3 x 10 ⁻¹¹ W/cm ² /sr to 3 x 10 ⁻⁵ W/cm ² /sr	5 % of Reading		





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MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION OR MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Radiant Intensity Response			Silicon Photodiode	OP-0037
	ance. Values vary per application	distance.		
At the listed Waveleng		11.0/ CD 1		
200 nm to 250 nm	1 x 10 ⁻⁸ W/sr to 2 x 10 ⁻³ W/sr	11 % of Reading		
250 nm to 400 nm	1 x 10 ⁻⁸ W/sr to 1 W/sr	4.5 % of Reading		
400 nm to 960 nm	1 x 10 ⁻⁸ W/sr to 3 W/sr	3 % of Reading		
960 nm to 1 000 nm	1 x 10 ⁻⁸ W/sr to 2 x 10 ⁻² W/sr	4.5 % of Reading		
1 000 nm to 1 100 nm	1 x 10 ⁻⁸ W/sr to 2 x 10 ⁻² W/sr	5 % of Reading		
Radiant Power Respon At the listed Waveleng				OP-0049
200 nm to 250 nm	4 x 10 ⁻¹² W to 4 x 10 ⁻⁷ W	11 % of Reading		
250 nm to 400 nm	4 x 10 ⁻¹² W to 3 x 10 ⁻⁴ W	4.5 % of Reading		OP-0106
960 nm to 1 000 nm	4 x 10 ⁻¹² W to 4 x 10 ⁻⁶ W	4.5 % of Reading		
1 000 nm to 1 100 nm	4 x 10 ⁻¹² W to 4 x 10 ⁻⁶ W	5 % of Reading	/	
400 nm to 960 nm	4 x 10 ⁻¹² W to 3 x 10 ⁻³ W	3 % of Reading		OP-0021, OP- 0022 OP-0039, OP-0106
Illuminance Sensitivity At the listed Waveleng	th ^F			OP-0070
400 nm to 700 nm	9 x 10 ⁻⁴ lx to 20 klx	2.4 % of Reading		
Luminance Sensitivity At the listed Wavelengths ^F				OP-0071
400 nm to 700 nm	2 x 10 ⁻⁴ cd/m ² to 60 kcd/m ²	2.4 % of Reading		
Luminous Intensity of a Standard Lamp At the listed Wavelengths ^F				OP-0081
400 nm to 700 nm	3 x 10 ⁻⁷ cd to 4 x 10 ⁺² cd	2.4 % of Reading		
Luminous Intensity Ser Based on 125 mm dista At the listed Waveleng	nce. Values vary per application	distance.		OP-0025
		2.4 % of Reading		
Luminous Power Sensi At the listed Waveleng				OP-0072
400 nm to 700 nm	3 x 10 ⁻⁸ lm to 8 lm	2.4 % of Reading		
Filter Transmission			Agilent UV-VIS	OP-0133
200 nm to 1 000 nm	1 % to 100 %	+/- 0.1 % of Reading	Spectroscopy	





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Optical Density ^F			Agilent UV-VIS	OP-0133
200 nm to 1 000 nm	Up to 2.5 OD	+/- 0.005 OD of Reading	Spectroscopy	
Wavelength			1	
200 nm to 1 000 nm	200 nm to 1 000 nm	+/- 0.5 nm of Reading	1	
Degrees Kelvin ^F			ILT950/960	OP-0155
Correlated Color Temperature (CCT) of Meters and Sources	2 000 K - 6 000 K	1 % of Reading	Spectrometer	
	6 001 K - 7 500K	1.2 % of Reading	1	
	7 501 K - 10 000K	1.7 % of Reading	1	

- 1. The CMC (Calibration and Measurement Capability) stated for calibrations included on this scope of accreditation represents the smallest measurement uncertainty attainable by the laboratory when performing a more or less routine calibration of a nearly ideal device under nearly ideal conditions. It is typically expressed at a confidence level of 95 % using a coverage factor k (usually equal to 2). The actual measurement uncertainty associated with a specific calibration performed by the laboratory will typically be larger than the CMC for the same calibration since capability and performance of the device being calibrated and the conditions related to the calibration may reasonably be expected to deviate from ideal to some degree.
- 2. The laboratories range of calibration capability for all disciplines for which they are accredited is the interval from the smallest calibrated standard to the largest calibrated standard used in performing the calibration. The low end of this range must be an attainable value for which the laboratory has or has access to the standard referenced. Verification of an indicated value of zero in the absence of a standard is common practice in the procedure for many calibrations but by its definition it does not constitute calibration of zero capacity.
- 3. The presence of a superscript F means that the laboratory performs calibration of the indicated parameter at its fixed location.
- 4. This is the primary site for all quality management system activities.